ABSTRACT

This document is to familiarize the user with the HDC3 family of devices by providing storage and handling guidelines, software configuration examples, and pseudo code. The HDC devices are integrated humidity and temperature sensors. The devices measures humidity through a capacitive polymer dielectric that has the capability to calibrate and restore humidity accuracy to meet product specifications. The HDC3 features a 2.5-mm × 2.5-mm WSON open-cavity package where the sensor is exposed directly to ambient air. On the HDC3021, the sensing element is protected during the assembly by factory-installed PI (Polyimide) tape. The HDC3022 sensing element is protected by a hydrophobic PTFE filter and is ideal for outdoor environments or anywhere condensation is expected. The HDC3021-Q1 is an AEC-Q100 qualified automotive grade humidity sensor. All of these HDC3 family devices are NIST traceable, factory calibrated and software-compatible with each other.

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Trademarks

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1 HDC302x Devices

1.1 HDC3020 in WSON

The HDC3020 is the standard WSON device in the HDC3020 family. The HDC3020 does not have additional protection over the relative humidity (RH) sensor window and the sensor is centered. The device is available in a 2.5-mm × 2.5-mm WSON package. When using the HDC3020, take care to ensure all the requirements are followed.

1.2 HDC3021 in WSON

The HDC3021 is pin-to-pin compatible with the HDC3020. Unlike the HDC3020, the sensor opening is protected by a factory-installed polyimide cover tape. The tape protects the humidity sensor element from pollutants that can be produced as part of the manufacturing process, such as surface mount technology (SMT) assembly, printed circuit board (PCB) wash, and conformal coating. The tape must be removed after the final stages of assembly for accurate measurement of relative humidity in the ambient environment.

1.3 HDC3022 in WSON

The HDC3022 is identical to the HDC3021, but instead of the removable assembly tape, this device features an IP67 rated hydrophobic protective PTFE membrane over the sensing element. This filter is intended to be left for the lifetime of the device, and protects with 99.99% filtration efficiency for particles down to 100 nm in size. The PTFE filter protects the device from dust, debris and condensation. The filter further protects the device during PCB wash and water submergences when the device is operational.
2 Storage and Handling Guidelines

2.1 Exposure to Contaminants

Humidity sensors are not standard ICs and therefore must not be exposed to articles or volatile chemicals such as solvents or other inorganic compounds. The opening in the package allows the sensor to sense the relative humidity in the air, but also exposes the polymer to the environment, making it susceptible to pollutants. Typical ambient conditions do not present a significant risk for chemical exposure but manufacturing and storage environments are a known source of volatile contamination. During assembly, a Kapton tape can be placed over the sensor opening to ensure that the device is not exposed to harmful chemicals. The HDC3021 is great for applications where the chance for chemical exposure is high since it comes with a factory installed kapton cover. The tape can be removed after this process, but the device is still susceptible to contamination.

Exposure to a range of chemicals must be avoided or minimized. Exposure of the following chemicals is known to cause drift of the humidity output readings which may be irreversible:

- Solvents such as:
  - Toluene: C\textsubscript{7}H\textsubscript{8}
  - Acetone: (CH\textsubscript{3})\textsubscript{2}CO
  - Ethanol: C\textsubscript{2}H\textsubscript{5}O
  - Methanol: CH\textsubscript{3}OH
  - Isopropyl Alcohol: C\textsubscript{3}H\textsubscript{8}O
  - Di-isopropyl Ether: C\textsubscript{6}H\textsubscript{14}O
  - Ethylene Glycol: (CH\textsubscript{2}OH)\textsubscript{2}
  - Ethyl Acetate: C\textsubscript{4}H\textsubscript{6}O\textsubscript{2}
  - Butyl Acetate: C\textsubscript{6}H\textsubscript{12}O\textsubscript{2}
  - Methyl Ethyl Ketone: CH\textsubscript{3}C(\textsubscript{O})CH\textsubscript{2}CH\textsubscript{3}

- Acids such as:
  - Hydrochloric Acid: HCl
  - Sulfuric Acid: H\textsubscript{2}SO\textsubscript{4}
  - Nitric Acid: HNO\textsubscript{3}

- Other chemicals, including:
  - Ketenes
  - Ammonia: NH\textsubscript{3}
  - Hydrogen Peroxide: H\textsubscript{2}O\textsubscript{2}
  - Ozone: O\textsubscript{3}
  - Formaldehyde: CH\textsubscript{2}O

Such chemicals are an integral part of epoxies, glues, adhesives, or reaction byproducts that outgas during baking and curing processes.

The sense layer must not have direct contact with cleaning agents such as a PCB wash after soldering. Applying cleaning agents to the sense layer may lead to drift of the RH output or even complete breakdown of the sensor. Avoid strong blasts from aerosol dusters and use only low-pressure, oil-free air dusting.

If it is necessary to expose the HDC to contaminants, concentration and exposure time must be reduced as much as feasible. Good ventilation (fresh air supply) aids in lowering the concentration of volatile chemicals, particularly solvents.
2.2 Chemical Analysis

The exposed layer of the HDC3020 can sense small changes in moisture content in the air. If the volatile compound is absorbed by the sense layer, it may degrade the sensor and lead to incorrect measurements. The below section describes the effect of some volatile chemicals that have been exposed to the HDC3020. The purpose of this section is to determine the chemical effects on RH accuracy of the HDC3020 sensors. The devices were exposed to volatile organic compounds (VOCs) that are common in commercial, industrial, and residential cleaning products.

The list of chemicals can be divided into two subsections categorized based on the level of exposure: Saturation and recovery testing and long-term exposure testing. These two subsections have different test procedures, methods of application and exposure quantities.

These sections go over some of the results that were observed during testing. The devices were measured against a chilled mirror and swept at 30°C. An average of the error between 10% to 90% RH was measured and graphed in the following sections. The exposure quantity was minimum and the chemical concentrations were below industry standards, therefore the devices did not exhibit significant change in humidity measurement. However, during manufacturing and assembly processes, the humidity sensors should not be exposed to the chemicals outlined in the above section. Any significant exposure can damage the polymer and it will be difficult to recover the sensor back to operating conditions. If the device will be assembled where chemical exposure is high, then a HDC3021 can be the right solution. Another option is to consider the HDC3022 which comes with a permanent Polytetrafluoroethylene (PTFE) filter that can block particles up to 100 nm.

If salt contamination occurs and the RH error is greater at higher humidities, then the sensor can be washed with deionized (DI) water.
2.2.1 Saturation and Recovery Tests

The chemicals in this list were exposed to the sensor only for a short period of time. Two conditions were evaluated for each chemical: a 30-second exposure and eight 30-second exposures over a period of 24 hours. Table 2-1 shows the chemicals in this list. The device operated at 3.3 V at 30°C and an average humidity error was calculated.

### Table 2-1. List of Chemicals for the Short-Term Exposure Test

<table>
<thead>
<tr>
<th>CHEMICAL</th>
<th>CONCENTRATION</th>
<th>OBSERVABLE DAMAGE</th>
<th>NUMBER OF HDC3020 UNITS</th>
</tr>
</thead>
<tbody>
<tr>
<td>Isopropyl alcohol</td>
<td>65.7% m/m</td>
<td>None</td>
<td>4 per exposure rating</td>
</tr>
<tr>
<td>Hydrogen Peroxide</td>
<td>7.35% m/m</td>
<td>None</td>
<td></td>
</tr>
<tr>
<td>Sodium Hypochlorite</td>
<td>4.5% m/m</td>
<td>Copper traces corroded</td>
<td></td>
</tr>
<tr>
<td>Iodophors</td>
<td>74 ppm m/m</td>
<td>None</td>
<td></td>
</tr>
<tr>
<td>Flux - Microcare Universal</td>
<td>100%</td>
<td>None</td>
<td></td>
</tr>
</tbody>
</table>

**30-Second exposure**: Five drops of each chemical was dropped directly on the sensor opening. After 30 seconds, the sensor was turned over to get rid of excess solution. After a minute of exposure, the device was cleaned to prevent further exposure.

Overall, Figure 2-1 shows there is not much change between the pre- and post tests for these chemicals other than a small negative gain.
**Multiple 30-second exposures:** Four HDC3020 devices followed a similar procedure as the 30-second test. The procedure was performed seven more times.

Overall, most of the chemicals did not have any major shift other than a negative gain.

However, exposure to Sodium Hypochlorite resulted in some corrosion on the copper traces on the board and some of the pins. To clean the PCB, the opening was protected using a kapton cover and it was cleaned using a horsehair brush and DI water. A humidity sweep shows that the devices had a very large negative gain shift, especially at higher humidity setpoints.

Exposure to Isopropyl Alcohol also resulted in some negative gain shift at lower humidity setpoints. Any further exposure would result to severe gain shifts.

*Figure 2-2* shows the sweeps for this exposure.

![Figure 2-2. Short-Term Exposure: Multiple Exposures](image-url)
2.2.2 Long-Term Exposure

Four samples per chemical were submitted for a long-term exposure test. These devices were exposed to gaseous forms in a sealed chamber for 21 days. Table 2-2 shows the chemicals in this test.

<table>
<thead>
<tr>
<th>CHEMICAL</th>
<th>CONCENTRATION (ppm)</th>
<th>OBSERVABLE DAMAGE</th>
</tr>
</thead>
<tbody>
<tr>
<td>Toluene</td>
<td>298 – 322</td>
<td>None</td>
</tr>
<tr>
<td>Xylene</td>
<td>108 – 131</td>
<td>None</td>
</tr>
<tr>
<td>Butyl Acetate</td>
<td>200 – 220</td>
<td>None</td>
</tr>
<tr>
<td>Formaldehyde</td>
<td>3 – 5</td>
<td>None</td>
</tr>
<tr>
<td>Sulfur Dioxide</td>
<td>5</td>
<td>None</td>
</tr>
<tr>
<td>Ethanol</td>
<td>862 – 1003</td>
<td>None</td>
</tr>
<tr>
<td>Methanol</td>
<td>195 – 260</td>
<td>None</td>
</tr>
<tr>
<td>Ammonia</td>
<td>34 – 35</td>
<td>None</td>
</tr>
<tr>
<td>Cigarette Smoke</td>
<td>Saturated</td>
<td>Staining and coating</td>
</tr>
</tbody>
</table>

For the devices exposed to cigarette smoke, smoke from a cigarette was blown into a chamber until it was saturated and the devices were not visible. Half a cigarette was used each time to saturate the chamber and the smoke inside the chamber was refreshed every day.

For the rest of the chemicals, the chemicals were administered using a syringe. The gases were refreshed every seven days by the chemist to ensure the concentration of the gases remained high.

Overall, most of the chemicals had an increased negative gain, but there were no significant offset changes on these parts. Figure 2-3 and Figure 2-4 show the results for these sweeps.
Figure 2-3. Long-Term Exposure Results
Figure 2-5 shows that exposure to cigarette smoke resulted in a huge negative gain and the RH error of these parts varied from 25% to –50% between 10% to 90% RH setpoints. The boards also had severe discoloration and visible residue on the sensor opening. The sensor was cleaned using air, but the device performance did not recover.
Figure 2-5. Long-Term Exposure To Cigarettes
2.3 Packaging and Storing

TI's humidity sensors are shipped in sealed anti-static tape and reel cavities. The sensors can be stored in a humidity and temperature-controlled environment after being removed from the tape and reel cavity prior to assembly. Storage temperature and humidity limitations are defined by the moisture sensitivity level (MSL) of the sensor. Refer to the application note *MSL Ratings and Reflow Profiles* for more details.

Do not store the humidity sensors within anti-static polyethylene bags or packing materials (pink foam/wrap), as these materials emit gases that can affect the sensor. TI recommends metallized, anti-static sealable bags for storage. Do not use adhesives or tape inside the storage container as outgassing can degrade the polymer as well.

2.3.1 Assembly

The HDC must be added in the last assembly step. In case the PCB passes through multiple solder cycles (as is the case for PCBs that have components on the top and bottom side), adding the HDC last reduces the risk of damage to the sensing polymer from contaminants or excessive heat. Contaminants such as those listed in *Exposure to Contaminants* must be avoided or minimized. Maximum assembly temperatures and exposure times must not be exceeded.

Note

It is important that no-clean solder paste is used and no board wash is applied once the sensor is assembled onto the PCB. To ensure proper device performance, these instructions should be communicated to board manufacturers before assembly.

2.3.2 Application in Extreme Environment

Some applications require the usage of the HDC in harsh environments. Ensure that the exposure of the sensor to the maximum limit of temperature and humidity operating conditions meets the data sheet guidelines. Limiting exposure to volatile organic compounds at high concentration and long exposure time is critical. Usage in harsh environments must be carefully tested and qualified.

Exposure to any aqueous solutions is highly discouraged. In the event some aqueous exposure cannot be avoided, TI recommends to use the HDC3022 and follow the guidelines below:

- Exposure to acids or bases may affect humidity output accuracy readings
- Bases are less damaging than acidic solutions. All acids must be considered damaging to the sensor. Etching substances such as H$_2$O$_2$ or NH$_3$ at high concentrations can be damaging to the sensor.
- Corrosive solutions at very low concentrations are not damaging to the sensor itself. However, take care to ensure that the solder contacts are not damaged.
3 Programming the HDC3020

The Functional Modes

The HDC3 has two modes of operation: sleep and measurement mode. After power up, the HDC3 enters sleep mode. In this mode, the device waits for I²C instruction to set the programmable low power mode, trigger a measurement/conversion, or read/write valid data. When a measurement is triggered, the device wakes from sleep mode to enter measurement mode. In measurement mode, the HDC3 converts temperature or humidity values from integrated sensors through an internal ADC.

Two different types of ADC conversions (measurement modes) are available in the HDC devices: Trigger-on Demand and Auto Measurement mode.

3.1 Trigger-On Demand

In this mode, I²C commands triggers each measurement conversion. After device power up, the device is placed in sleep mode waiting for an input.

To configure the device to collect both the humidity and temperature data in a single acquisition mode, select TRIGGER ON DEMAND (MSB HEX CODE 24) in the command table along with the appropriate low power mode selection. The device will exit from sleep mode and perform a single measurement. Figure 3-1 shows the Trigger-on Demand mode.

![Figure 3-1. Flowchart for Trigger-On Demand Mode](image-url)
3.2 Auto Measurement

Auto Measurement mode is a continuous operation mode. The user can select the measurement frequency between 10 samples a second to 1 sample every 2 seconds.

To configure the device to collect both the humidity and temperature data in continuous mode, select the desired Auto Measurement mode and low power mode duration from the command table. To obtain the temperature and humidity values, the user can issue commands 0x0E & 0x00. After placing the device into the auto measurement mode desired (Table 8-3 in the HDC3020 data sheet), the user should issue command code 0xE0 0x00 at coinciding time intervals to read out the temperature and relative humidity measurement values.

![Flowchart for Auto Measurement Mode](image)

**Figure 3-2. Flowchart for Auto Measurement Mode**
3.3 Programming the CRC

The Cyclical Redundancy Check (CRC) computation module can be used for message transfer and safety system checks. The 8-bit CRC checksum transmitted after each data word is generated by a CRC algorithm. The CRC covers the contents of 2 bytes of transmitted data. To calculate the checksum, only these two previously transmitted data bytes are used.

<table>
<thead>
<tr>
<th>PROPERTY</th>
<th>VALUE</th>
</tr>
</thead>
<tbody>
<tr>
<td>Name</td>
<td>CRC-8 / NRSC-5</td>
</tr>
<tr>
<td>Width</td>
<td>8 bit</td>
</tr>
<tr>
<td>Protected Data</td>
<td>Read and/or write Data</td>
</tr>
<tr>
<td>Polynomial</td>
<td>$0x31 \ (x^8 + x^5 + x^4 + 1)$</td>
</tr>
<tr>
<td>Initialization</td>
<td>0xFF</td>
</tr>
<tr>
<td>Example</td>
<td>CRC of 0xABAB is 0x72</td>
</tr>
</tbody>
</table>

### 3.3.1 CRC C Code

The following code snippet describes how to generate an 8-bit CRC code in C for the HDC3x devices.

```c
#include <stdio.h>

unsigned char crcHDC3(unsigned char msg[], int msglen) {
  unsigned char crc = 0xFF;
  for (int byte = 0; byte < msglen; byte++) {
    crc ^= msg[byte];
    for (int bit = 0; bit < 8; bit++) {
      if (crc & 0x80)
        crc = (crc << 1) ^ 0x31;
      else
        crc = (crc << 1);
    }
  }
  return crc;
}

void main(int argc, char *argv[]) {
  unsigned char msg[20];
  int msglen = (argc > 1) ? (argc - 1) : 2;
  msg[0] = 0xAB;
  msg[1] = 0xCD;
  for (int i = 1; i < argc; i++) {
    sscanf(argv[i], "%X", &msg[i-1]);
  }
  printf("crc" 0x%X\n", crcHDC3(msg, msglen));
}
```
3.4 Condensation Removal

Certain environments can force the temperature to drop below the dew point. During such an event, condensation can occur on the device. The sensor opening will be blocked and this can impact accurate sensor readings. In such situations, the integrated heater on the HDC3020 can be beneficial to remove any condensation and can continue reading error free measurements.

Note

The HDC3020 should only be used in a non-condensing environment. The recommended humidity operating range is 10 to 90% RH (non-condensing) over –20°C to 70°C. Prolonged operation beyond these ranges may shift the sensor reading with a slow recovery time. Excess condensation could degrade sensor performance and might make it harder to recover.

The HDC3 comes with a configurable heater to allow customers to use the heater based on their application and the amount of power needed to evaporate the condensation. The highest power (lowest resistance) offered on this device is 35.92 Ω and the lowest power (highest resistance) is 1996 Ω. This setting can be configured as needed but the recommended resistances are outlined in Table 3-2.

The recommended operating condition for the heater can be set between 1.62 V to 5.5 V. The condensation removal is layout-dependent as some layouts would need more power or more time to evaporate the moisture. The recommended layout can be found in the Layout Example section of the data sheet. Users can configure a setting between 25% and 100% and characterize a setting based on the layout and application. Users must note that they need to calculate and write the CRC to the device based on the heater configuration.

Calculating the dew point (DP) from the temperature and humidity measurements can be important when it comes to this feature. If the temperature drops below the DP, the device can be placed in an environment where the temperature gets above the DP and the heater can be enabled. The user can also leverage the ALERT output, which is triggered when the part crosses preset temp and %RH levels. The timing of this process can take a couple of minutes, sometimes even five minutes until the device can read the temperature and humidity accurately. When the %RH reading goes to zero % (or near it), the heater can be subsequently turned off to allow the device to cool down. Cooling of the device can take several minutes, but the temperature measurement will continue to run to ensure the device goes back to normal operating condition before restarting the device for normal service.

Refer to the flowchart in Figure 3-3 to configure and enable the heater.
The integrated heater evaporates moisture that forms on top of the humidity sensor, but does not remove any contaminants. Any contaminant residue, if present, may impact the accuracy of the humidity sensor and can cause drift. If the device experiences drift due to contamination or precipitation, refer to the Offset Error Correction section.
3.5 Offset Error Correction

The Offset Error Correction Algorithm calibrates the device and corrects any observed sensor drift that may be encountered due to device mishandling or exposure to contaminants. There are cases where the devices have been permanently shifted as a result of accelerated aging test exposure, chemical exposure, or device mishandling. Heating the humidity sensor to a high temperature for a long period of time (to bake it) can remove the drift from prolonged exposure to extreme conditions and/or harsh contaminants, but this is not practical after the sensor is in the field for many applications. Devices that exhibit this shift can be expensive to replace and would also consume a lot of time for technicians to replace the system module. Many polymer-based sensors are susceptible to these shifts and finding a solution to correct this kind of error is greatly desired. This algorithm can reduce cost and potentially improve the life of your product.

This section will cover the electrical, mechanical design and the recommended layout required to correct the humidity offset that is observed on the HDC3020. The offset error correction algorithm calibrates the device and corrects any observed sensor drift that may be encountered due to device mishandling or exposure to contaminants.

This feature should be operated using the Trigger-on Demand mode. When the algorithm is done running, the user can continue to run the device in any other mode of their choosing. This feature can work well for devices that exhibit a positive humidity shift.

This technique uses the built-in heater to eliminate the drift. The triggering of the firmware routine could be accomplished any number of ways, from a cloud-connected handset application, button press, triggered periodically, or just on a power-on reset (POR). The exact method implemented is at the discretion of the developer and also based on the application. In the below examples, a software interrupt was used to trigger the execution of the calibration routine. The algorithm can be run as many times as the users would prefer. However, TI recommends to run the algorithm once a year or whenever it is suspected that the device was contaminated by some chemical.

The unit(s) under testing must have their heater switched on and observed for highest temperature that can be achieved. In this effort, the different packages and layouts each have their own impact on the heater performance. Figure 3-4 describes the different layout considerations that can be implemented on the HDC devices. The EVM and the layout with the cutout would require lower current to execute the offset error correction algorithm. However, the layout that has little to no thermal isolation would require a lot more current to execute this command. The device has a recommended 125°C maximum temperature, but certain layouts cannot support this temperature rise. The first step is to see how hot the parts can get on a given layout (if not starting with a cutout), and then change the layout (if possible) to get best results.

The PCB thickness and layout of the board play a significant role in the time it takes for the active slope of curve calculation in algorithm to complete – on all board designs shown above, though – a loop time of that calculation which resulted in correction of the sensor back to well within the datasheet limits or better was found.

Figure 3-4. Thermal Isolation Examples
The HDC3020s heater power setting is also customizable. Users can choose their power setting based on their operating voltage, layout, and overall application, and this can help users reduce their power consumption. Table 3-2 shows some common power settings that were tested along with their approximated power consumptions. If a user plans to modify the heater configuration, a thorough power analysis must be generated along with a look up table.

<table>
<thead>
<tr>
<th>HEATER POWER SETTING</th>
<th>HEATER HEX CODE</th>
<th>CRC</th>
<th>TYPICAL HEATER RESISTANCE (Ω)</th>
<th>TYPICAL CURRENT AT 3.3VDC (A)</th>
<th>TYPICAL POWER AT 3.3VDC (W)</th>
<th>TYPICAL CURRENT AT 5VDC (A)</th>
<th>TYPICAL POWER AT 5VDC (W)</th>
</tr>
</thead>
<tbody>
<tr>
<td>25%</td>
<td>0x009F</td>
<td>0x96</td>
<td>150.35</td>
<td>21.95 mA</td>
<td>72.43 mW</td>
<td>33.26 mA</td>
<td>166.29 mW</td>
</tr>
<tr>
<td>50%</td>
<td>0x03FF</td>
<td>0x00</td>
<td>71.04911037</td>
<td>46.45 mA</td>
<td>153.27 mW</td>
<td>70.38 mA</td>
<td>351.87 mW</td>
</tr>
<tr>
<td>100%</td>
<td>0x3FFF</td>
<td>0x06</td>
<td>35.92</td>
<td>91.89 mA</td>
<td>303.22 mW</td>
<td>139.22 mA</td>
<td>696.1 mW</td>
</tr>
</tbody>
</table>

A characterization table or a look up table (LUT) should be used to apply the correct humidity offset for these devices. TI provides a LUT for two suggested layouts, and one of the recommended layouts can be found in the data sheet. The other suggested layout can be found at the end of this section. The tables were characterized using a Temperature and Humidity chamber (ex: TE1007H) and a high-accuracy temperature and humidity reference (ex: chilled mirror), and the test records the temperature rise from initial conditions until the device reaches the humidity offset. Table 3-2 in the next section records the values between 10% to 45%RH and between 15°C and 30°C.

Figure 3-5 describes the steps required to use the LUT. The humidity value obtained after running this algorithm is the offset that must be subtracted from the device to correct the error. You can apply this offset to the device using the offset register. Refer to the data sheet for more information.
Start HD3020 offset correction

Measure Temp and %RH (one shot) and store these values as initial conditions

Retrieve cut off temperature from Look Up Table based on initial conditions

Turn Heater on

Read Temp and %RH

Calculate heat rise (Current temperature – initial temperature)

Is heat rise ≥ cutoff temperature

NO

YES

Store %RH as the offset

Turn Heater off

Calculate offset code and CRC

Write device offset to the offset register

Return to normal sensing operation

Figure 3-5. Flowchart Demonstrating the Offset Error Correction Algorithm

The algorithm can be executed at any time from normal operation, and successive approximation occurs each time you run it. When the offset is large, running drift correction more than once can help it reach a lower error. The look up table is initialized at the start of the firmware execution. After a read of the ambient conditions, the logic is used to pick out the row and column location value to use for heat rise cutoff temperature. Figure 3-6 shows a quick example of how the overall rise temperature can be selected from a LUT and what value should be subtracted from the offset register. In Figure 3-6, Rx (the first column) represents the humidity %RH set points.
that the device measures before the heater starts. CX (The first row) represents the temperature that the device measures before the heater is run.

Figure 3-6. Look Up Table (LUT) Example

Look up tables based on two separate layouts are described below. If your layouts have a similar thickness, similar cutouts, and the same thermal isolation, then these look up tables can be used.
3.5.1 Offset Error Correction Example With a Fingerboard

The fingerboard was designed for test and characterization purposes. The fingerboard has a dimension of 677 mils x 942 mils (17.2 mm x 23.9 mm) and an overall thickness of 62 mils (1.6 mm). The fingerboard has two cutouts (approximately 55 mils, or 1.4 mm) on either side of the DUT which makes this a good layout to verify the offset error correction algorithm. They are made with Rogers RO4350B dielectric (instead of FR4). The thermal pad is soldered down, but the thermal pad itself is not grounded, it’s just a floating copper pad. However, even with these cutouts, the board itself is pretty thick which led to some heat rise challenges during this process. If a user wants to design a board similar to this, ensure that the board is not too thick.

Table 3-3 and Table 3-4 show the look up tables for the HDC3020 fingerboard. The LUT was generated using 30 HDC3020 devices and were tested between 15°C – 30°C in increments of 5°C and between 10% – 45% RH in increments of 2.5%RH. The look up tables here were generated at 3.3 V and 5 V, and both were operated at the full power setting. All the devices were placed in the chamber and the temperature rise was calculated for each temperature and humidity set point.

Table 3-3. Look Up Table (LUT) for a Fingerboard Operated at Heater Full Power at 3.3 V

<table>
<thead>
<tr>
<th>Temp [°C]</th>
<th>15</th>
<th>20</th>
<th>25</th>
<th>30</th>
</tr>
</thead>
<tbody>
<tr>
<td>%RH</td>
<td></td>
<td></td>
<td></td>
<td></td>
</tr>
<tr>
<td>10</td>
<td>32.99248</td>
<td>30.94213</td>
<td>31.77977</td>
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### Table 3-3. Look Up Table (LUT) for a Fingerboard Operated at Heater Full Power at 3.3 V (continued)

<table>
<thead>
<tr>
<th>Temp [°C]</th>
<th>15%RH</th>
<th>20%RH</th>
<th>25%RH</th>
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<tbody>
<tr>
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<td>45.68952</td>
<td>44.20545</td>
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### Table 3-4. Look Up Table (LUT) for Fingerboard Operated at Heater Half Power at 5 V

<table>
<thead>
<tr>
<th>RH [%]/Temp [°C]</th>
<th>15%RH</th>
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## 4 References

For related documentation, see the following:

2. Texas Instruments, *HDC302x-Q1 Automotive 0.5%RH Digital Relative Humidity Sensor, 0.19%RH/yr Long Term Drift, 4s Response, Offset Error Correction, 0.1°C Temperature Sensor* data sheet
3. Texas Instruments, *MSL Ratings and Reflow Profiles* application note

## 5 Revision History

NOTE: Page numbers for previous revisions may differ from page numbers in the current version.

<table>
<thead>
<tr>
<th>Changes from Revision B (August 2022) to Revision C (July 2023)</th>
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<tr>
<td>• Changed document title from: HDC3 Silicon Users Guide to: HDC302x Silicon Users Guide</td>
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<tr>
<td>• Changed Section 3.1</td>
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<td>• Changed Figure 3-2</td>
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<td>• Changed minimum recommended supply voltage from: 2.7 V to: 1.62 V</td>
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<td>• Changed Figure 3-3</td>
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<td>• Added mill to mm conversions in Section 3.5.1</td>
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<td>• Changed Section 2.2.2</td>
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<td>• Added content for the HDC3021 and HDC3022 device releases</td>
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1. **Delivery:** TI delivers TI evaluation boards, kits, or modules, including any accompanying demonstration software, components, and/or documentation which may be provided together or separately (collectively, an “EVM” or “EVMs”) to the User (“User”) in accordance with the terms set forth herein. User's acceptance of the EVM is expressly subject to the following terms.

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2.3 TI’s sole liability shall be at its option to repair or replace EVMs that fail to conform to the warranty set forth above, or credit User’s account for such EVM. TI’s liability under this warranty shall be limited to EVMs that are returned during the warranty period to the address designated by TI and that are determined by TI not to conform to such warranty. If TI elects to repair or replace such EVM, TI shall have a reasonable time to repair such EVM or provide replacements. Repaired EVMs shall be warranted for the remainder of the original warranty period. Replaced EVMs shall be warranted for a new full ninety (90) day warranty period.

**WARNING**

Evaluation Kits are intended solely for use by technically qualified, professional electronics experts who are familiar with the dangers and application risks associated with handling electrical mechanical components, systems, and subsystems.

User shall operate the Evaluation Kit within TI’s recommended guidelines and any applicable legal or environmental requirements as well as reasonable and customary safeguards. Failure to set up and/or operate the Evaluation Kit within TI’s recommended guidelines may result in personal injury or death or property damage. Proper set up entails following TI’s instructions for electrical ratings of interface circuits such as input, output and electrical loads.

**NOTE:**

EXPOSURE TO ELECTROSTATIC DISCHARGE (ESD) MAY CAUSE DEGREDATION OR FAILURE OF THE EVALUATION KIT; TI RECOMMENDS STORAGE OF THE EVALUATION KIT IN A PROTECTIVE ESD BAG.
3 Regulatory Notices:

3.1 United States

3.1.1 Notice applicable to EVMs not FCC-Approved:

FCC NOTICE: This kit is designed to allow product developers to evaluate electronic components, circuitry, or software associated with the kit to determine whether to incorporate such items in a finished product and software developers to write software applications for use with the end product. This kit is not a finished product and when assembled may not be resold or otherwise marketed unless all required FCC equipment authorizations are first obtained. Operation is subject to the condition that this product not cause harmful interference to licensed radio stations and that this product accept harmful interference. Unless the assembled kit is designed to operate under part 15, part 18 or part 95 of this chapter, the operator of the kit must operate under the authority of an FCC license holder or must secure an experimental authorization under part 5 of this chapter.

3.1.2 For EVMs annotated as FCC – FEDERAL COMMUNICATIONS COMMISSION Part 15 Compliant:

CAUTION
This device complies with part 15 of the FCC Rules. Operation is subject to the following two conditions: (1) This device may not cause harmful interference, and (2) this device must accept any interference received, including interference that may cause undesired operation.

Changes or modifications not expressly approved by the party responsible for compliance could void the user’s authority to operate the equipment.

FCC Interference Statement for Class A EVM devices
NOTE: This equipment has been tested and found to comply with the limits for a Class A digital device, pursuant to part 15 of the FCC Rules. These limits are designed to provide reasonable protection against harmful interference when the equipment is operated in a commercial environment. This equipment generates, uses, and can radiate radio frequency energy and, if not installed and used in accordance with the instruction manual, may cause harmful interference to radio communications. Operation of this equipment in a residential area is likely to cause harmful interference in which case the user will be required to correct the interference at his own expense.

FCC Interference Statement for Class B EVM devices
NOTE: This equipment has been tested and found to comply with the limits for a Class B digital device, pursuant to part 15 of the FCC Rules. These limits are designed to provide reasonable protection against harmful interference in a residential installation. This equipment generates, uses and can radiate radio frequency energy and, if not installed and used in accordance with the instructions, may cause harmful interference to radio communications. However, there is no guarantee that interference will not occur in a particular installation. If this equipment does cause harmful interference to radio or television reception, which can be determined by turning the equipment off and on, the user is encouraged to try to correct the interference by one or more of the following measures:

- Reorient or relocate the receiving antenna.
- Increase the separation between the equipment and receiver.
- Connect the equipment into an outlet on a circuit different from that to which the receiver is connected.
- Consult the dealer or an experienced radio/TV technician for help.

3.2 Canada

3.2.1 For EVMs issued with an Industry Canada Certificate of Conformance to RSS-210 or RSS-247
Concerning EVMs Including Radio Transmitters:

This device complies with Industry Canada license-exempt RSSs. Operation is subject to the following two conditions:
(1) this device may not cause interference, and (2) this device must accept any interference, including interference that may cause undesired operation of the device.

Concernant les EVMs avec appareils radio:
Le présent appareil est conforme aux CNR d’Industrie Canada applicables aux appareils radio exempts de licence. L’exploitation est autorisée aux deux conditions suivantes: (1) l’appareil ne doit pas produire de brouillage, et (2) l’utilisateur de l’appareil doit accepter tout brouillage radioélectrique subi, même si le brouillage est susceptible d’en compromettre le fonctionnement.

Concerning EVMs Including Detachable Antennas:

Under Industry Canada regulations, this radio transmitter may only operate using an antenna of a type and maximum (or lesser) gain approved for the transmitter by Industry Canada. To reduce potential radio interference to other users, the antenna type and its gain should be so chosen that the equivalent isotropically radiated power (e.i.r.p.) is not more than that necessary for successful communication. This radio transmitter has been approved by Industry Canada to operate with the antenna types listed in the user guide with the maximum permissible gain and required antenna impedance for each antenna type indicated. Antenna types not included in this list, having a gain greater than the maximum gain indicated for that type, are strictly prohibited for use with this device.
Concernant les EVMs avec antennes détachables

Conformément à la réglementation d'Industrie Canada, le présent émetteur radio peut fonctionner avec une antenne d'un type et d'un gain maximal (ou inférieur) approuvé pour l'émetteur par Industrie Canada. Dans le but de réduire les risques de brouillage radioélectrique à l'intention des autres utilisateurs, il faut choisir le type d'antenne et son gain de sorte que la puissance isotrope rayonnée équivalente (p.i.r.e.) ne dépasse pas l'intensité nécessaire à l'établissement d'une communication satisfaisante. Le présent émetteur radio a été approuvé par Industrie Canada pour fonctionner avec les types d'antenne énumérés dans le manuel d'usage et ayant un gain admissible maximal et l'impédance requise pour chaque type d'antenne. Les types d'antenne non inclus dans cette liste, ou dont le gain est supérieur au gain maximal indiqué, sont strictement interdits pour l'exploitation de l'émetteur.

3.3 Japan

3.3.1 Notice for EVMs delivered in Japan: Please see http://www.tij.co.jp/lsds/ti_ja/general/eStore/notice_01.page 日本国内に輸入される評価用キット、ボードについては、次のところをご覧ください。

3.3.2 Notice for Users of EVMs Considered “Radio Frequency Products” in Japan: EVMs entering Japan may not be certified by TI as conforming to Technical Regulations of Radio Law of Japan.

If User uses EVMs in Japan, not certified to Technical Regulations of Radio Law of Japan, User is required to follow the instructions set forth by Radio Law of Japan, which includes, but is not limited to, the instructions below with respect to EVMs (which for the avoidance of doubt are stated strictly for convenience and should be verified by User):

1. Use EVMs in a shielded room or any other test facility as defined in the notification #173 issued by Ministry of Internal Affairs and Communications on March 28, 2006, based on Sub-section 1.1 of Article 6 of the Ministry’s Rule for Enforcement of Radio Law of Japan,
2. Use EVMs only after User obtains the license of Test Radio Station as provided in Radio Law of Japan with respect to EVMs, or
3. Use of EVMs only after User obtains the Technical Regulations Conformity Certification as provided in Radio Law of Japan with respect to EVMs. Also, do not transfer EVMs, unless User gives the same notice above to the transferee. Please note that if User does not follow the instructions above, User will be subject to penalties of Radio Law of Japan.

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日本テキサス・インスツルメンツ株式会社
東京都新宿区西新宿6丁目24番1号
西新宿三井ビル

3.3.3 Notice for EVMs for Power Line Communication: Please see http://www.tij.co.jp/lsds/ti_ja/general/eStore/notice_02.page 電力線送信装置についての開発キットをお使いになる際の注意事項については、次のところをご覧ください。
https://www.ti.com/ja-jp/legal/notice-for-evaluation-kits-for-power-line-communication.html

3.4 European Union

3.4.1 For EVMs subject to EU Directive 2014/30/EU (Electromagnetic Compatibility Directive):

This is a class A product intended for use in environments other than domestic environments that are connected to a low-voltage power-supply network that supplies buildings used for domestic purposes. In a domestic environment this product may cause radio interference in which case the user may be required to take adequate measures.
4 EVM Use Restrictions and Warnings:

4.1 EVMS ARE NOT FOR USE IN FUNCTIONAL SAFETY AND/OR SAFETY CRITICAL EVALUATIONS, INCLUDING BUT NOT LIMITED TO EVALUATIONS OF LIFE SUPPORT APPLICATIONS.

4.2 User must read and apply the user guide and other available documentation provided by TI regarding the EVM prior to handling or using the EVM, including without limitation any warning or restriction notices. The notices contain important safety information related to, for example, temperatures and voltages.

4.3 Safety-Related Warnings and Restrictions:

4.3.1 User shall operate the EVM within TI’s recommended specifications and environmental considerations stated in the user guide, other available documentation provided by TI, and any other applicable requirements and employ reasonable and customary safeguards. Exceeding the specified performance ratings and specifications (including but not limited to input and output voltage, current, power, and environmental ranges) for the EVM may cause personal injury or death, or property damage. If there are questions concerning performance ratings and specifications, User should contact a TI field representative prior to connecting interface electronics including input power and intended loads. Any loads applied outside of the specified output range may also result in unintended and/or inaccurate operation and/or possible permanent damage to the EVM and/or interface electronics. Please consult the EVM user guide prior to connecting any load to the EVM output. If there is uncertainty as to the load specification, please contact a TI field representative. During normal operation, even with the inputs and outputs kept within the specified allowable ranges, some circuit components may have elevated case temperatures. These components include but are not limited to linear regulators, switching transistors, pass transistors, current sense resistors, and heat sinks, which can be identified using the information in the associated documentation. When working with the EVM, please be aware that the EVM may become very warm.

4.3.2 EVMs are intended solely for use by technically qualified, professional electronics experts who are familiar with the dangers and application risks associated with handling electrical mechanical components, systems, and subsystems. User assumes all responsibility and liability for proper and safe handling and use of the EVM by User or its employees, affiliates, contractors or designees. User assumes all responsibility and liability to ensure that any interfaces (electronic and/or mechanical) between the EVM and any human body are designed with suitable isolation and means to safely limit accessible leakage currents to minimize the risk of electrical shock hazard. User assumes all responsibility and liability for any improper or unsafe handling or use of the EVM by User or its employees, affiliates, contractors or designees.

4.4 User assumes all responsibility and liability to determine whether the EVM is subject to any applicable international, federal, state, or local laws and regulations related to User’s handling and use of the EVM and, if applicable, User assumes all responsibility and liability for proper disposal and recycling of the EVM consistent with all applicable international, federal, state, and local requirements.

5. Accuracy of Information: To the extent TI provides information on the availability and function of EVMs, TI attempts to be as accurate as possible. However, TI does not warrant the accuracy of EVM descriptions, EVM availability or other information on its websites as accurate, complete, reliable, current, or error-free.

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7. User’s Indemnity Obligations and Representations. User will defend, indemnify and hold TI, its licensors and their representatives harmless from and against any and all claims, damages, losses, expenses, costs and liabilities (collectively, “Claims”) arising out of or in connection with any handling or use of the EVM that is not in accordance with these terms. This obligation shall apply whether claims arise under statute, regulation, or the law of tort, contract or any other legal theory, and even if the EVM fails to perform as described or expected.
8. **Limitations on Damages and Liability:**

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8.2 **Specific Limitations.** IN NO EVENT SHALL TI'S AGGREGATE LIABILITY FROM ANY USE OF AN EVM PROVIDED HEREUNDER, INCLUDING FROM ANY WARRANTY, INDEMNITY OR OTHER OBLIGATION ARISING OUT OF OR IN CONNECTION WITH THESE TERMS, EXCEED THE TOTAL AMOUNT PAID TO TI BY USER FOR THE PARTICULAR EVM(S) AT ISSUE DURING THE PRIOR TWELVE (12) MONTHS WITH RESPECT TO WHICH LOSSES OR DAMAGES ARE CLAIMED. THE EXISTENCE OF MORE THAN ONE CLAIM SHALL NOT ENLARGE OR EXTEND THIS LIMIT.

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10. **Governing Law:** These terms and conditions shall be governed by and interpreted in accordance with the laws of the State of Texas, without reference to conflict-of-laws principles. User agrees that non-exclusive jurisdiction for any dispute arising out of or relating to these terms and conditions lies within courts located in the State of Texas and consents to venue in Dallas County, Texas. Notwithstanding the foregoing, any judgment may be enforced in any United States or foreign court, and TI may seek injunctive relief in any United States or foreign court.

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